Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,684	TRIEU, HAI H.
Examiner	Art Unit
Bruce E. Snow	3738

SEARCHED					
Class	Subclass	Date	Examiner		
623	17.11- 17.16	4/18/2007	BES		
	i				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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